

Notice of References Cited	Application/Control No. 10/820,294		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Andrew Schechter		Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,335,775	01-2002	Iwamura et al.	349/125
*	B	US-6,549,256	04-2003	Bryan-Brown et al.	349/128
*	C	US-6,476,894	11-2002	Kikkawa, Hironori	349/123
*	D	US-6,549,257	04-2003	Liu, Hong-Da	349/129
*	E	US-6,567,144	05-2003	Kim et al.	349/128
*	F	US-6,753,551	06-2004	Cheng, Hsin-An	257/79
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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